

**Notice of References Cited**Application/Control No.  
**09/820,364**Applicant(s)/Patent Under Reexam  
**Kanai et al.**Examiner  
**T. Chen**Art Unit  
**2171**

Page 1 of 1

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		Document Number Country Code-Number-Kind Code	Date MM-YYYY <sup>1</sup>	Name	Classification <sup>2</sup>	
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**FOREIGN PATENT DOCUMENTS**

		Document Number Country Code-Number-Kind Code	Date MM-YYYY <sup>1</sup>	Country	Name	Classification <sup>2</sup>	
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**NON-PATENT DOCUMENTS**

		Include, as applicable: Author, Title, Date, Publisher, Edition or Volume, Pertinent Pages
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